IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of

Takashi OGAWA :

Appln. No. [not yet assigned] :

Filed: August 18, 2006

For: SEMICONDUCTOR INSPECTION

METHOD AND SYSTEM

THEREFOR : Docket No. S005-5850(PCT)

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PRELIMINARY AMENDMENT CANCELING CLAIMS TO REDUCE FILING FEE

S I R:

Applicant preliminarily amends his application before calculation of the filing fee as follows:

BY EXPRESS MAIL ON AUGUST 18, 2006 (EV 666 011 623 US)